BSC080N03LS G N-Channel Enhancement Mode MOSFET

Description

The BSC080N03LS G uses advanced trench technology

to provide excellent R_{DS(ON)}, low gate charge and

operation with gate voltages as low as 4.5V. This

device is suitable for use as a

Battery protection or in other Switching application.

General Features

 $V_{DS} = 30V I_{D} = 70A$

 $R_{DS(ON)} < 7 \text{ m}\Omega \text{ V}_{GS}=10 \text{V}$

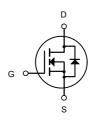
Application

Battery protection

Load switch

Uninterruptible power supply

DFN5X6-8L



N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
BSC080N03LS G	DFN5X6-8L	080N03LS XXXX	5000

Absolute Maximum Ratings (Tc=25 ℃ unless otherwise noted)

Symbol	Parameter	Rating	Units	
Vos	Drain-Source Voltage	30	V	
Vgs	Gate-Source Voltage	V		
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	Α		
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	40	А	
I _D @T _A =25°C	Continuous Drain Current, Vcs @ 10V1	30	А	
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	18	А	
Ідм	Pulsed Drain Current ²	140	А	
EAS	Single Pulse Avalanche Energy ³	115.2	mJ	
las	Avalanche Current	48	Α	
P _D @T _C =25°C	Total Power Dissipation ⁴	59	W	
P _D @T _A =25°C	Total Power Dissipation⁴	Total Power Dissipation ⁴ 2		
Тѕтс	Storage Temperature Range			
TJ	Operating Junction Temperature Range -55 to 15		°C	
Reja	Thermal Resistance Junction-Ambient ¹ 62		°CM	
Reuc	Thermal Resistance Junction-Case ¹	2.1	°C/W	



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V
∆BVpss/∆Tj	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.028		V/°C
RDS(ON)		V _{GS} =10V , I _D =30A		5.7	7	
	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =15A		11	13	$\boldsymbol{m}\Omega$
VGS(th)	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	1.2		2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	VGS-VDS , ID -250UA		-6.16		mV/°C
lpss	Drain-Source Leakage Current	V_{DS} =24V , V_{GS} =0V , T_J =25 $^{\circ}$ C			1	
1000	_	V _{DS} =24V , V _{GS} =0V , T _J =55°C			5	uA
Igss	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =30A		43		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.7		Ω
Qg	Total Gate Charge (4.5V)			20		
Qgs	Gate-Source Charge	V _{DS} =15V , V _{GS} =4.5V , I _D =15A		7.6		nC
Q _{gd}	Gate-Drain Charge			7.2		
T _{d(on)}	Turn-On Delay Time			7.8		
Tr	Rise Time	V _{DD} =15V , V _{GS} =10V ,		15		ns
T _d (off)	Turn-Off Delay Time	R _G =3.3		37.3		
Tf	Fall Time	l _D =15A		10.6		
Ciss	Input Capacitance			2295		
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		267		pF
Crss	Reverse Transfer Capacitance			210		
ls	Continuous Source Current ^{1,5}				81	Α
lsм	Pulsed Source Current ^{2,5}	V _G =V _D =0V , Force Current			160	Α
VsD	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1	V
t _{rr}	Reverse Recovery Time			14		nS
Qrr	Reverse Recovery Charge	$_{\text{IF}=30\text{A}}$, dl/dt=100A/ μ s , $_{\text{J}=25^{\circ}\text{C}}$		5		nC

Note

^{1.} The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

^{2.}The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

^{3.} The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS} =48A

^{4.} The power dissipation is limited by 150°C junction temperature

^{5.} The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

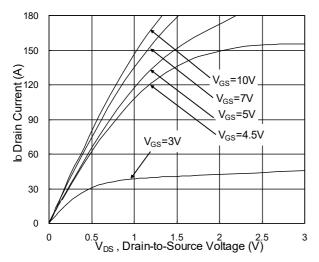


Fig.1 Typical Output Characteristics

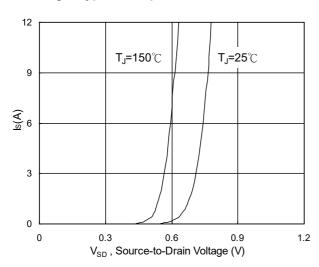


Fig.3 Forward Characteristics of Reverse

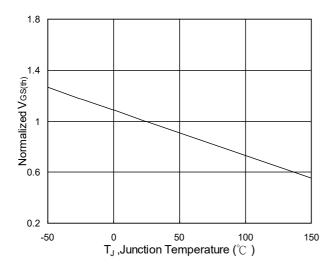


Fig.5 Normalized V_{GS(th)} vs. T_J

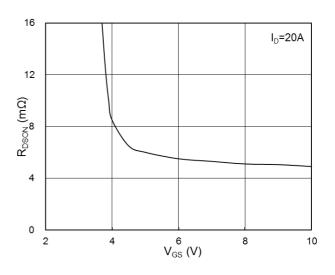


Fig.2 On-Resistance vs. G-S Voltage

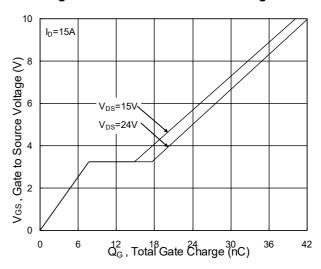


Fig.4 Gate-Charge Characteristics

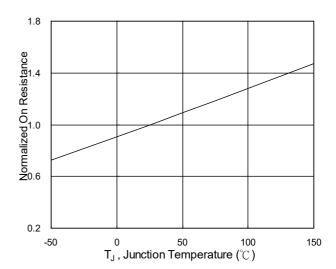
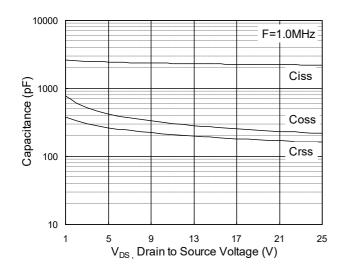


Fig.6 Normalized R_{DSON} vs. T_J





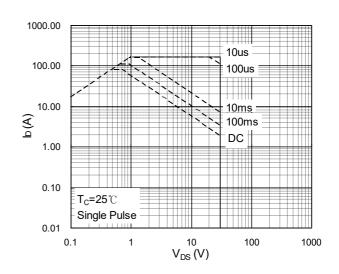


Fig.7 Capacitance

Fig.8 Safe Operating Area

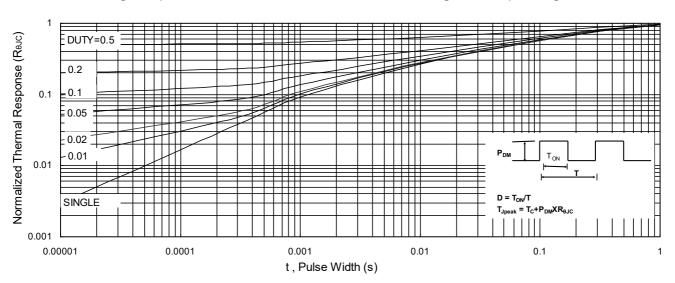


Fig.9 Normalized Maximum Transient Thermal Impedance

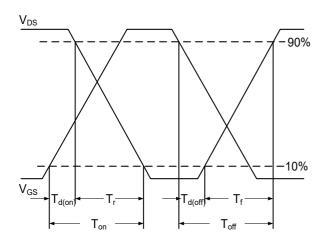


Fig.10 Switching Time Waveform

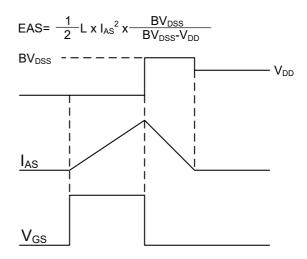
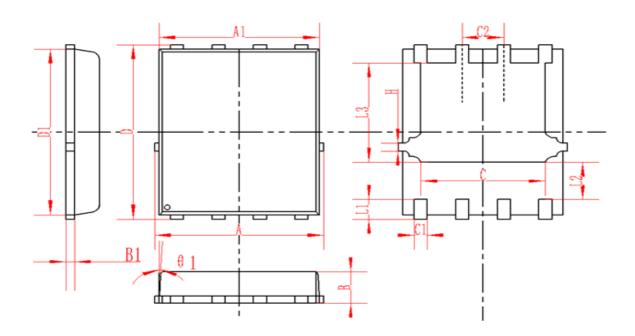


Fig.11 Unclamped Inductive Switching Waveform

DFN5X6-8L Package Information



SYMBOL	MM		INCH			
	MIN	NOM	MAX	MIN	NOM	MAX
А	4.95	5	5.05	0.195	0.197	0.199
A1	4.82	4.9	4.98	0.190	0.193	0.196
D	5.98	6	6.02	0.235	0.236	0.237
D1	5.67	5.75	5.83	0.223	0.226	0.230
В	0.9	0.95	1	0.035	0.037	0.039
B1		0.254REF			0.010REF	
С	3.95	4	4.05	0.156	0.157	0.159
C1	0.35	0.4	0.45	0.014	0.016	0.018
C2		1.27TYP			0.5TYP	
θ1	8°	10°	12°	8°	10°	12°
L1	0.63	0.64	0.65	0.025	0.025	0.026
L2	1.2	1.3	1.4	0.047	0.051	0.055
L3	3.415	3.42	3.425	0.134	0.135	0.135
Н	0.24	0.25	0.26	0.009	0.010	0.010



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